

**ISSUED BY** Shenzhen BALUN Technology Co., Ltd.

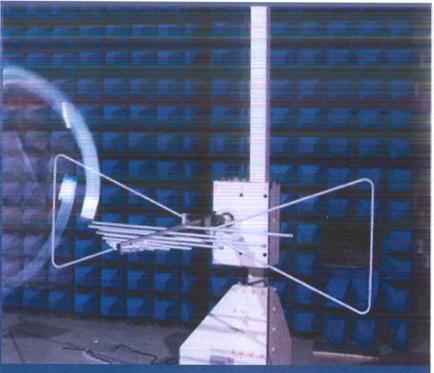


**FOR** 

# Wireless Charger

**ISSUED TO** BCS Automotive Interface Solutions (Suzhou) Co., Ltd.

No.2052 Taidong Road Xiangcheng Economic Development District, 215143 Suzhou China



Tested by: Date Out Approved by: Wei Yanquan (Chief Engineer) Date dell. mo

**EUT Name: Wireless Charger** 

Report No.: BL-EC2090870-402

Model Name: WPC003-1

Brand Name:

BCS

Test Standard: FCC ID:

47 CFR Part 15 Subpart C

2AXPS-WPC003-1

Test Conclusion: Pass Test Date:

Oct. 09, 2020 ~ Oct. 15, 2020

Date of Issue: Oct. 19, 2020

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# **Revision History**

VersionIssue DateRevisionsRev. 01Oct. 19, 2020Initial Issue

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## 1 GENERAL INFORMATION

# 1.1 Identification of the Testing Laboratory

Company Name	Shenzhen BALUN Technology Co., Ltd.
Address	Block B, 1st FL, Baisha Science and Technology Park, Shahe Xi
	Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China
Phone Number	+86 755 6685 0100

# 1.2 Identification of the Responsible Testing Location

Test Location	Shenzhen BALUN Technology Co., Ltd.		
Addraga	Block B, 1st FL, Baisha Science and Technology Park, Shahe Xi		
Address	Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China		
	The laboratory has been listed by Industry Canada to perform		
	electromagnetic emission measurements. The recognition numbers		
	of test site are 11524A-1.		
	The laboratory is a testing organization accredited by FCC as a		
Accreditation	accredited testing laboratory. The designation number is CN1196.		
Certificate	The laboratory is a testing organization accredited by American		
Certificate	Association for Laboratory Accreditation(A2LA) according to ISO/IEC		
	17025.The accreditation certificate is 4344.01.		
	The laboratory is a testing organization accredited by China National		
	Accreditation Service for Conformity Assessment (CNAS) according		
	to ISO/IEC 17025. The accreditation certificate number is L6791.		
	All measurement facilities used to collect the measurement data are		
Description	located at Block B, FL 1, Baisha Science and Technology Park, Shahe		
Description	Xi Road, Nanshan District, Shenzhen, Guangdong Province, P. R.		
	China 518055		

# 1.3 Laboratory Condition

_	
Ambient Temperature	20°C to 25°C
Ambient Relative Humidity	45% to 55%
Ambient Pressure	100 kPa to 102 kPa



## 1.4 Announce

- (1) The test report reference to the report template version v2.7.
- (2) The test report is invalid if not marked with the signatures of the persons responsible for preparing and approving the test report.
- (3) The test report is invalid if there is any evidence and/or falsification.
- (4) The results documented in this report apply only to the tested sample, under the conditions and modes of operation as described herein.
- (5) This document may not be altered or revised in any way unless done so by BALUN and all revisions are duly noted in the revisions section.
- (6) Content of the test report, in part or in full, cannot be used for publicity and/or promotional purposes without prior written approval from the laboratory.
- (7) The laboratory is only responsible for the data released by the laboratory, except for the part provided by the applicant.



## **2 PRODUCT INFORMATION**

# 2.1 Applicant Information

Applicant	BCS Automotive Interface Solutions (Suzhou) Co.,Ltd.
A dalua a a	No.2052 Taidong Road Xiangcheng Economic Development
Address	District,215143 Suzhou China

## 2.2 Manufacturer Information

Manufacturer	BCS Automotive Interface Solutions (Suzhou) Co.,Ltd.
Address	No.2052 Taidong Road Xiangcheng Economic Development
	District,215143 Suzhou China

# 2.3 Factory Information

Factory	N/A
Address	N/A

# 2.4 General Description for Equipment under Test (EUT)

EUT Name	Wireless Charger	
Model Name Under Test	WPC003-1	
Series Model Name	N/A	
Description of Model	N/A	
name differentiation	N/A	
Serial Number	WPC00314A0602	
Hardware Version	A4	
Software Version	A7	
Dimensions (Approx.)	N/A	
Weight (Approx.)	N/A	



# 2.5 Ancillary Equipment

N/A

# 2.6 Technical Information

Antenna Type

	Network and Wireless connectivity	QI
The req	uirement for the following	technical information of the EUT was tested in this report:
Operating Frequency 110kHz~115kHz		110kHz~115kHz
		Mobile
	Product Type	☐ Portable

Coil Antenna



## 3 SUMMARY OF TEST RESULTS

### 3.1 Test Standards

No.	Identity	Document Title	
	47 CFR Part 15,		
1	Subpart C	Intentional Radiators	
	(10-1-18 Edition)		
	ANSI C63.10-2013	American National Standard for Testing Unlicensed Wireless	
2		Devices	

### 3.2 Verdict

No.	Description	FCC Rule	Test Verdict	Result
1	Radiated Emission	15.209,15.215(b)	Pass	Annex A.1
2	Conducted Emission, AC Ports	15.207	Pass	Annex A.2
3	20 dB Bandwidth	15.215(c)	Pass	Annex A.3

Note 1: The system was configured for testing in a typical fashion (as normally used by a typical user)

Note 2: The test channel is not fixed depending on the load (The load is simulated charging state), we only show one channel for typical load testing in this report.

## 3.3 Test Uncertainty

The following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

Measurement	Value
Conducted emissions (9 kHz-30 MHz)	2.96 dB
Radiated emissions (30 MHz-1 GHz)	3.66 dB
Radiated emissions (1 GHz-18 GHz)	5.57 dB



# **4 GENERAL TEST CONFIGURATIONS**

## **4.1 Test Environments**

Relative Humidity	45% to 55%				
Atmospheric Pressure	100 kPa to 102 kPa				
Temperature	NT (Normal Temperature)	+22°C to +25°C			
Working Voltage of the EUT	NV (Normal Voltage)	DC 13.5 V			

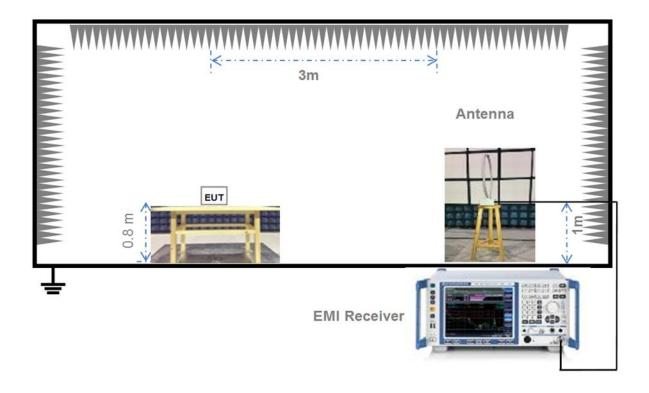
# 4.2 Test Equipment List

Description	Manufacturer	Model	Serial No.	Cal. Date	Cal. Due	
EMI Receiver	ROHDE&SCHWARZ	ESRP	101036	2020.06.09	2021.06.08	
Test Antenna-						
Loop(9 kHz-30	SCHWARZBECK	FMZB 1519	1519-037	2019.10.29	2021.10.28	
MHz)						
Test Antenna-						
Bi-Log(30 MHz-	SCHWARZBECK	VULB 9163	9163-624	2019.07.02	2021.07.01	
3 GHz)						
Anechoic	EMC Electronic Co.,	20.10*11.60*7	N/A	2018.08.08	2021.08.07	
Chamber	Ltd	.35m	IN/A	2016.06.06	2021.00.07	
EMI Receiver	KEYSIGHT	N9010B	MY5711030	2020.06.09	2021.06.08	
LIVII IXECEIVEI	KLISIGITI	1490100	9	2020.00.09	2021.00.08	
LISN	SCHWARZBECK	NSLK 8127	8127-687	2020.06.09	2021.06.08	
Shielded	YiHeng Electronic	3.4m*3.1m*2.	N/A	2018.08.16	2021.08.15	
Enclosure	Co., Ltd	8m	IN/A	2010.00.10	2021.00.15	
Test Software	BALUN	BL410_E	V19.918			



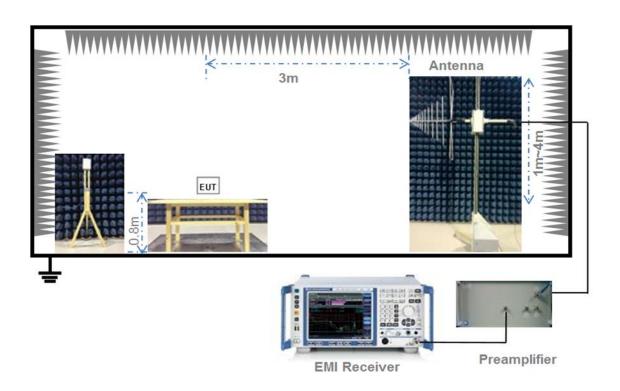
# 4.3 Test Setups

## Test Setup 1



For Radiated Emission Test (Below 30 MHz))

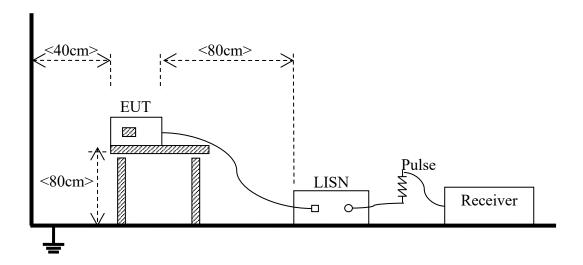
## Test Setup 2



(For Radiated Emission Test (30 MHz-1 GHz))



## Test Setup 3



(For Conducted Emission, AC Ports Test)



## 5 TEST ITEMS

### 5.1 Emission Tests

#### 5.1.1 Radiated Emission

#### 5.1.1.1 Limit

Frequency (MHz)	Field Strength (μV/m)	Measurement Distance (m)
0.009 - 0.490	2400/F(kHz)	300
0.490 - 1.705	24000/F(kHz)	30
1.705 - 30.0	30	30
30 - 88	100	3
88 - 216	150	3
216 - 960	200	3
Above 960	500	3

#### NOTE:

- 1) Field Strength ( $dB\mu V/m$ ) = 20\*log [Field Strength ( $\mu V/m$ )].
- 2) In the emission tables above, the tighter limit applies at the band edges.
- 3) For above 1000 MHz, limit field strength of harmonics: 54 dBuV/m@3 m (AV) and 74 dBuV/m@3 m (PK)
- 4) At frequencies below 30 MHz, measurements may be performed at a distance closer than that specified in the regulations, when performing measurements at a closer distance than specified, the results shall be extrapolated to the specified distance by either making measurements at a minimum of two distances on at least one radial to determine the proper extrapolation factor or by using the square of an inverse linear distance extrapolation factor (40 dB/decade). For example, at the frequency 9 kHz, limit @10m = 20\*log (2400/f) + 40log (dlimit/dmeasure) where limit = 300m, dmeasure=10m. limit @10m = 20\*log (2400/9) + 40log (300/10) = 107.5 (dBµV/m).
- 5) At frequencies at or above 30 MHz, measurements may be performed at a distance other than what is specified provided, When performing measurements at a distance other than that specified, the results shall be extrapolated to the specified distance using an extrapolation factor of 20 dB/decade (inverse linear-distance for field strength measurements; inverse-linear-distance-squared for power density measurements). For example, at the frequency 30 MHz, limit @10m =  $20*\log (100) + 20\log (dlimit/dmeasure)$  where limit = 3m, dmeasure=10m. limit @10m =  $20*\log (3/10) = 29.5 (dB\mu V/m)$ .

#### 5.1.1.2 Test Setup

Refer to 4.3 section (test setup 1 to test setup 2) for radiated emission test, the photo of test setup please refer to ANNEX B.

#### 5.1.1.3 Test Procedure

All Spurious Emission tests were performed in X, Y, Z axis direction. And only the worst axis test condition was recorded in this test report.

An initial pre-scan was performed in the chamber using the EMI Receiver in peak detection mode. Quasi-peak measurements were conducted based on the peak sweep graph. The EUT was measured by Bi-Log antenna with 2 orthogonal polarities.

#### 5.1.1.4 Test Result

Please refer to ANNEX A.1.



## NOTE:

1. Results (dBuV/m) = Reading (dBuV) + Factor (dB/m)

The reading level is calculated by software which is not shown in the sheet

- 2. Factor (dB/m) = Antenna Factor (dB/m) + Cable Factor (dB) Amplifier Gain (dB)
- 3. Over limit = Results Limit.



#### 5.1.2 Conducted Emission

#### 5.1.2.1 Test Limit

Frequency range	Conducted Limit (dBμV)					
(MHz)	Quasi-peak	Average				
0.15 - 0.50	66 to 56	56 to 46				
0.50 - 5	56	46				
5 - 30	60	50				

#### NOTE:

- 1) The limit is applicable to Class B ITE.
- 2) The lower limit shall apply at the band edges.
- 3) The limit decreases linearly with the logarithm of the frequency in the range 0.15 0.50 MHz.

#### 5.1.2.2 Test Setup

Refer to 4.3 section test (test setup 3) for conducted emission, the photo of test setup please refer to ANNEX B.

#### 5.1.2.3 Test Procedure

The EUT is connected to the power mains through a LISN which provides  $50 \Omega/50 \mu H$  of coupling impedance for the measuring instrument. The test frequency range is from 150 kHz to 30 MHz. The maximum conducted interference is searched using Peak (PK), Quasi-peak (QP) and Average (AV) detectors; the emission levels that are more than the AV and QP limits, and that have narrow margins from the AV and QP limits will be re-measured with AV and QP detectors. Tests for both L phase and N phase lines of the power mains connected to the EUT are performed.

Devices subject to Part 15 must be tested for all available U.S. voltages and frequencies (such as a nominal 120 VAC, 50/60 Hz and 240 VAC, 50/60 Hz) for which the device is capable of operation. A device rated for 50/60 Hz operation need not be tested at both frequencies provided the radiated and line conducted emissions are the same at both frequencies.

#### 5.1.2.4 Test Result

Please refer to ANNEX A.2.

#### NOTE:

1. Results (dBuV/m) = Reading (dBuV) + Factor (dB/m)

The reading level is calculated by software which is not shown in the sheet

- 2. Factor = Insertion loss + Cable loss
- 3. Over limit = Results Limit.



#### 5.1.3 20 dB Bandwidth

#### 5.1.3.1 Limit

FCC §15.215(c)

The 20 dB bandwidth is known as the 99% emission bandwidth, or 20 dB bandwidth (10\*log1%=20 dB) taking the total RF output power.

### 5.1.3.2 Test Setup

Refer to 4.3 section test (test setup 1) for test setup description for the antenna port. The photo of test setup please refer to ANNEX B.

#### 5.1.3.3 Test Procedure

Use the following spectrum analyzer settings:

Span = approximately 2 to 3 times the 20 dB bandwidth, centered on a hopping channel

RBW ≥ 1% of the 20 dB bandwidth

VBW ≥ RBW

Sweep = auto

Detector function = peak

Trace = max hold

The EUT should be transmitting at its maximum data rate, Allow the trace to stabilize.

#### 5.1.3.4 Test Result

Please refer to ANNEX A.3.



## ANNEX A TEST RESULTS

### A.1 Radiated Emission

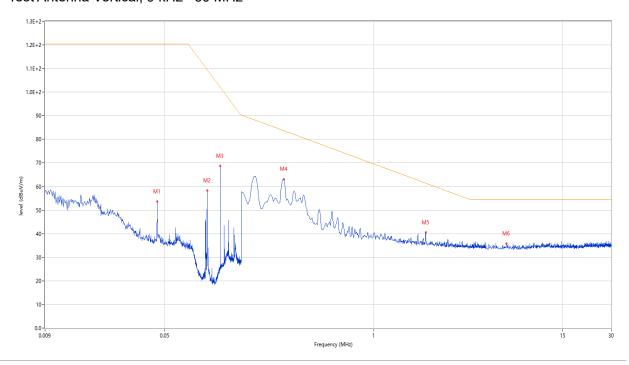
Note <sup>1</sup>: The symbol of "--" in the table which means not application.

Note <sup>2</sup>: For the test data above 1 GHz, according the ANSI C63.4-2014, where limits are specified for both average and peak (or quasi-peak) detector functions, if the peak (or quasi-peak) measured value complies with the average limit, it is unnecessary to perform an average measurement.

Note <sup>3</sup>: The marked spikes near 0.111 MHz with circle should be ignored because they are carrier frequency.

#### QI Test Data and Plots

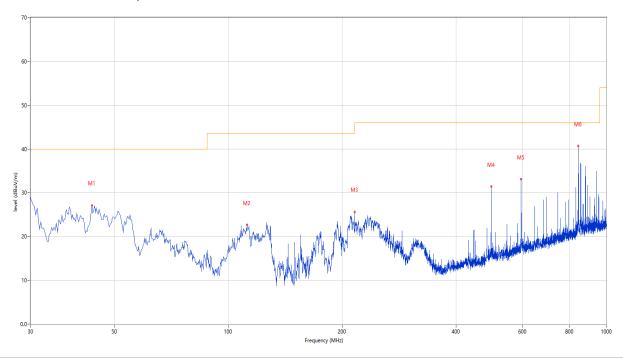
### A.1.1 Test Antenna Vertical, 9 kHz -30 MHz



No.	Frequency	Results	Factor	Limit	Over Limit	Detector	Table	Height	Antenna	Verdict
	(MHz)	(dBuV/m)	(dB)	(dBuV/m)	(dB)		(Degree)	(cm)		
1	0.045	53.70	12.84	102.9	-49.20	Peak	149.00	100	Vertical	Pass
2	0.092	58.32	13.14	99.8	-41.48	Peak	146.00	100	Vertical	Pass
3	0.111	68.66	13.24	99.0	-30.34	Peak	197.00	100	Vertical	Pass
4	0.276	63.07	14.59	95.0	-31.93	Peak	138.00	100	Vertical	Pass
5	2.103	40.62	20.51	85.4	-44.78	Peak	138.00	100	Vertical	Pass
6	6.698	35.89	20.55	77.2	-41.31	Peak	290.00	100	Vertical	Pass



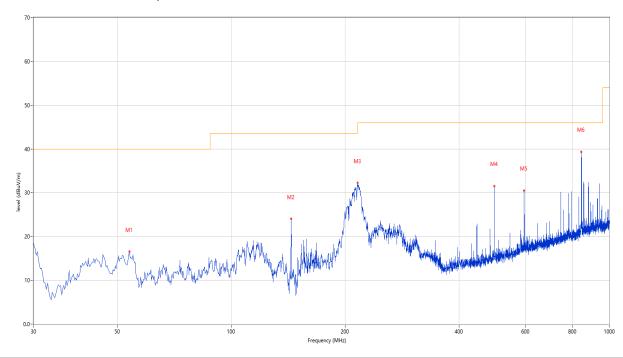
## A.1.2 Test Antenna Vertical, 30 MHz –1 GHz



No.	Frequency	Results	Factor	Limit	Over Limit	Detector	Table	Height	Antenna	Verdict
	(MHz)	(dBuV/m)	(dB)	(dBuV/m)	(dB)		(Degree)	(cm)		
1	43.580	27.04	-25.37	40.0	-12.96	Peak	152.00	100	Vertical	Pass
2	112.207	22.61	-27.63	43.5	-20.89	Peak	256.00	150	Vertical	Pass
3	215.998	25.64	-26.01	43.5	-17.86	Peak	241.00	100	Vertical	Pass
4	495.842	31.36	-19.28	46.0	-14.64	Peak	1.00	200	Vertical	Pass
5	595.025	33.07	-16.53	46.0	-12.93	Peak	182.00	100	Vertical	Pass
6	842.860	40.69	-12.30	46.0	-5.31	Peak	188.00	100	Vertical	Pass



## A.1.3 Test Antenna Horizontal, 30 MHz –1 GHz



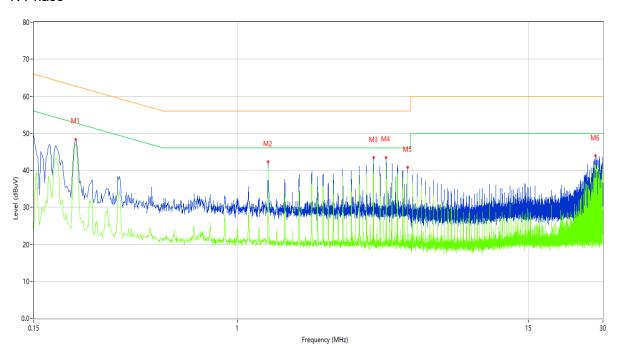
No.	Frequency	Results	Factor	Limit	Over Limit	Detector	Table	Height	Antenna	Verdict
	(MHz)	(dBuV/m)	(dB)	(dBuV/m)	(dB)		(Degree)	(cm)		
1	53.765	16.52	-25.44	40.0	-23.48	Peak	0.00	200	Horizontal	Pass
2	143.975	23.99	-31.12	43.5	-19.51	Peak	101.00	200	Horizontal	Pass
3	215.755	32.24	-25.85	43.5	-11.26	Peak	123.00	100	Horizontal	Pass
4	496.085	31.57	-19.31	46.0	-14.43	Peak	122.00	200	Horizontal	Pass
5	595.025	30.49	-16.53	46.0	-15.51	Peak	159.00	100	Horizontal	Pass
6	843.102	39.35	-12.27	46.0	-6.65	Peak	1.00	100	Horizontal	Pass



# A.2 Conducted Emission

# QI Test Data and Plots

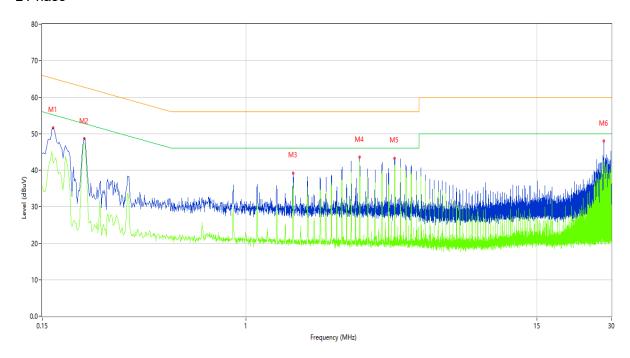
## A.2.1 N Phase



No.	Frequency	Results	Factor	Limit	Over Limit	Detector	Line	Verdict
	(MHz)	(dBuV)	(dB)	(dBuV)	(dB)			
1*	0.222	47.71	11.30	62.74	-15.03	QP	N	Pass
1**	0.222	47.16	11.30	52.74	-5.58	AV	N	Pass
2*	1.330	38.93	11.23	56.00	-17.07	QP	N	Pass
2**	1.330	40.59	11.23	46.00	-5.41	AV	N	Pass
3*	3.548	40.04	11.31	56.00	-15.96	QP	N	Pass
3**	3.548	42.08	11.31	46.00	-3.92	AV	N	Pass
4*	3.990	40.30	11.22	56.00	-15.70	QP	N	Pass
4**	3.990	41.45	11.22	46.00	-4.55	AV	N	Pass
5*	4.878	37.91	11.29	56.00	-18.09	QP	N	Pass
5**	4.878	39.12	11.29	46.00	-6.88	AV	N	Pass
6*	27.932	41.88	11.32	60.00	-18.12	QP	N	Pass
6**	27.932	41.25	11.32	50.00	-8.75	AV	N	Pass



## A.2.2 L Phase



No.	Frequency	Results	Factor	Limit	Over Limit	Detector	Line	Verdict
	(MHz)	(dBuV)	(dB)	(dBuV)	(dB)			
1*	0.166	49.35	11.09	65.16	-15.81	QP	L	Pass
1**	0.166	41.99	11.09	55.16	-13.17	AV	L	Pass
2*	0.222	48.24	11.30	62.74	-14.50	QP	L	Pass
2**	0.222	47.32	11.30	52.74	-5.42	AV	L	Pass
3*	1.552	35.48	11.13	56.00	-20.52	QP	L	Pass
3**	1.552	36.59	11.13	46.00	-9.41	AV	L	Pass
4*	2.882	40.42	11.25	56.00	-15.58	QP	L	Pass
4**	2.882	42.27	11.25	46.00	-3.73	AV	L	Pass
5*	3.990	40.42	11.22	56.00	-15.58	QP	L	Pass
5**	3.990	41.09	11.22	46.00	-4.91	AV	L	Pass
6*	27.932	42.36	11.32	60.00	-17.64	QP	L	Pass
6**	27.932	38.76	11.32	50.00	-11.24	AV	L	Pass



### A.3 20 dB Bandwidth

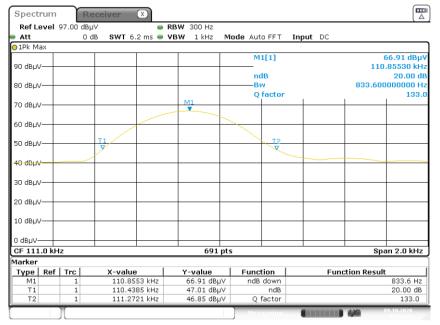
#### QI Test Data and Plots

**Test Data** 

Frequency	Emission Bandwidth(20dB down)	Occupied Bandwidth(99%)
(kHz)	(Hz)	(Hz)
111.0	833.600	819.103

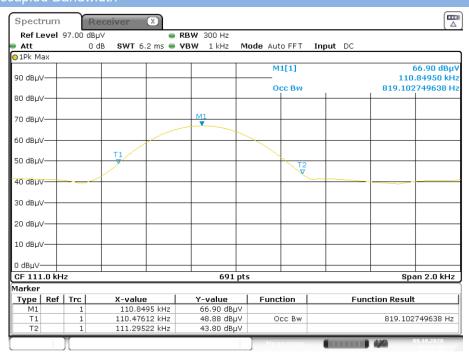
#### Test plots

#### Emission Bandwidth



Date: 9.OCT.2020 05:54:20

#### 99% Occupied Bandwidth



Date: 9.0CT.2020 05:52:39



## ANNEX B TEST SETUP PHOTOS

Please refer the document "BL-EC2090870-AR.PDF".

## ANNEX C EUT EXTERNAL PHOTOS

Please refer the document "BL-EC2090870-AW.PDF".

## ANNEX D EUT INTERNAL PHOTOS

Please refer the document "BL-EC2090870-AI.PDF".

--END OF REPORT--